

# CARBON NANOTUBE TECHNOLOGY FOR MICRO GAS CHROMATOGRAPH AND CHEMICAL NANOSENSORS

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## Abstract

Multiwall carbon nanotubes (MWCNT), with number of wall layers in range of 5 - 30 and lengths up to 500 micrometers are synthesized by microwave plasma enhanced chemical vapor deposition (MPCVD) using evaporated multi-layer Fe catalyst. The growth of MWCNT inside a deep reactive ion etched (DRIE) Si channel of the pre-concentrator focuser (PCF) section of an on-chip micro gas chromatograph ( $\mu$ GC) is reported for the first time by applying the catalyst selectively in the channels. A MWCNT based chemical nanosensor has also been fabricated using the same technology and initial test results are reported.

## CARBON NANOTUBE TECHNOLOGY FOR $\mu$ GC CHANNELS

An intensive study of tube density, diameter and catalyst application led to the selection of Fe/Ti (10 nm/10nm) double layer, evaporated on p-type Si wafers, for growth of high quality multiwall carbon nanotubes (MWCNT). While Fe serves a catalyst, the Ti layer provides a diffusion barrier. The samples were treated in hydrogen plasma for 10 minutes at 40 torr using  $H_2$  flow rate of 20 sccm before increasing the microwave power to 1800 W. After the hydrogen plasma treatment, the MWCNT were grown at 650 °C by introducing  $CH_4$  at a flow rate of 10 sccm into the growth chamber. The growth rate was approximately 10 micro-meters per minute [3].

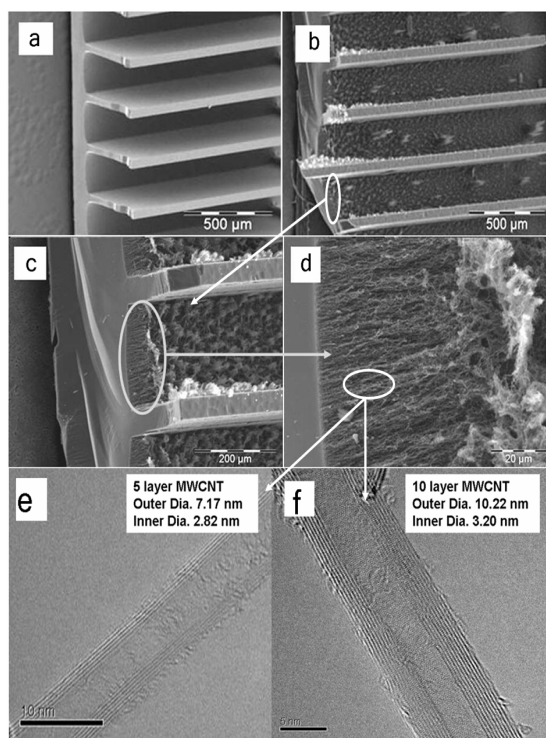
The preconcentrator channels were fabricated in Si by deep reactive ion etching (DRIE) as shown in Figure 1(a) followed by evaporation of Fe/Ti (10 nm/10nm) double layer at  $5 \times 10^{-6}$  torr. Photoresist, left at the top of the channels after DRIE, was used to lift off the unwanted metal layers on the top surface of Si channels. After a MWCNT growth time of 15 minutes in the channels the sample was cooled down to room temperature in vacuum [1] [2]. Figure 1(b-d) shows the sample after the growth. The tube length and density are approximately 50  $\mu$ m and  $4.2 \times 10^9$  cm<sup>-2</sup>, respectively. The TEM pictures (JEOL 2010F field emission TEM), indicating number of wall layers in the range of 5 – 10 and shown in Fig. 1(e-f), were taken on a separate set of samples.

## CARBON NANOTUBE NANOSENSOR TECHNOLOGY

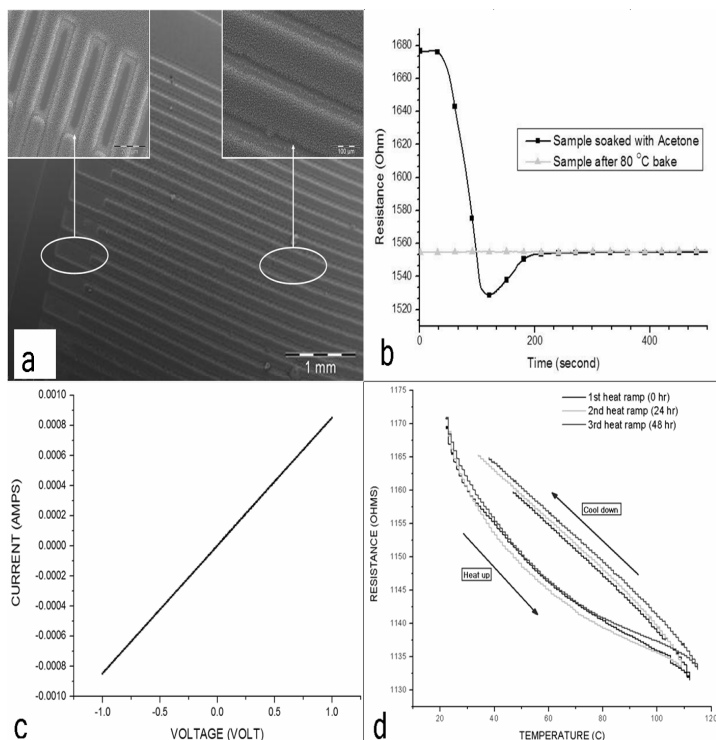
The sensor structure was fabricated on a quartz substrate using growth conditions described above. The Fe/Ti metal layer was patterned to form the electrodes separated by 200  $\mu$ m. As the tubes are 400  $\mu$ m tall, the tubes from the neighboring electrodes overlap to form the sensor structure as shown in Figure 2(a).

## Sensor Testing

The fabricated sensor was placed on a temperature-controlled stage inside a high vacuum chamber kept at  $2 \times 10^{-7}$  torr. The surface temperature of the sensor structure was measured by a K type thermocouple. A Keithley 2010 multimeter was used to monitor the resistance change of the sensor and a HP 4140B pA meter/ DC voltage source was used to characterize the current-voltage (I-V) characteristics. Figure 2(b) shows the response of the sensor after exposure to acetone in air at room temperature, indicating shorter response times than those reported in the literature [4]. The resistance of the exposed sample decreases below that of the control sample. Figure 2(c) shows the I-V characteristics of the sensor structure in vacuum at 25 °C. The structure shows a linear current-voltage response which indicates there is no junction between the MWCNT and the metal electrode [5]. Figure 2(d) shows the resistance- temperature response of the sensor structure in vacuum. When the sample was heated up, the pressure inside the vacuum chamber increased from  $2 \times 10^{-7}$  torr to  $1 \times 10^{-6}$  torr. A resistance hysteresis was also observed during the temperature cycle. This phenomenon appeared even after 48 hours inside the vacuum chamber and two temperature cycles.



**Figure 1 (a) - (d) SEM of the PCF; (e),(f) TEM of the MWCNT.**



**Figure 2 (a) SEM of the sensor; (b) Resistance measurement in air, (c) I-V characteristic, (d) Resistance-Temperature response of the sensor in vacuum.**

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